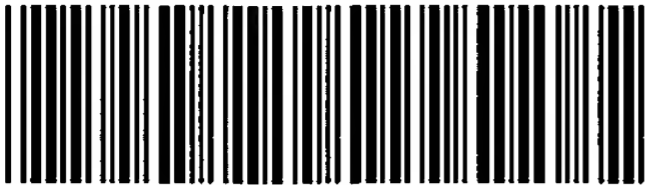


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/790,803	TANAHASHI ET AL.	
	Examiner	Art Unit	
	Alain L. Bashore	1762	

SEARCHED			
Class	Subclass	Date	Examiner
428	694TM 694TS	9/17/2006	AB
428	900;65.3	9/17/2006	AB
428	65.7	9/17/2006	ab

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
427	599;598	9/17/2006	AB
427	128	9/17/2006	AB
428	694TM 694	9/17/2006	AB
428/900,65.3,65.7		9/17/2006	ab

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
previous search updated	9/17/2006	AB
Inventor name search	9/17/2006	AB